

**Notice of References Cited**

Application/Control No.

10/532,588

Applicant(s)/Patent Under  
Reexamination  
WRAY ET AL.

Examiner

OTIS L. THOMPSON, JR

Art Unit

4183

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,452,905 B1	09-2002	Smith et al.	370/236.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Viktoria Elek, Gunnar Karlsson and Rober Ronngren, "Admission Control Based on End-to-End Measurements", 26-30 March 2000, IEEE, Volume 2, Pages 623-630
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.